

Notice of References Cited	Application/Control No. 10/709,104	Applicant(s)/Patent Under Reexamination CHEN, HENG-CHIEN	
	Examiner Anna Deng	Art Unit 2191	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,082,603 B2	07-2006	Hisatake, Derrick I.	717/173
*	B	US-2002/0095474 A1	07-2002	Boys, Donald R.	709/217
*	C	US-2005/0144616 A1	06-2005	Hammond et al.	717/173
*	D	US-2004/0068721 A1	04-2004	O'Neill et al.	717/168
*	E	US-6,975,612 B1	12-2005	Razavi et al.	370/338
*	F	US-2002/0087668 A1	07-2002	San Martin et al.	709/221
*	G	US-6,477,543 B1	11-2002	Huang et al.	707/200
*	H	US-5,008,814 A	04-1991	Mathur, Ashish	709/221
*	I	US-6,308,205 B1	10-2001	Carcerano et al.	709/221
*	J	US-2005/0102662 A1	05-2005	Samsalovic et al.	717/168
*	K	US-2005/0083846 A1	04-2005	Bahl, Pradeep	370/236
*	L	US-2005/0028001 A1	02-2005	Huang et al.	713/200
*	M	US-6,484,257 B1	11-2002	Ellis, Alonzo	713/153

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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